# 74CBTLV3257 Quad 1-of-2 multiplexer/demultiplexer Rev. 6 — 11 December 2017

**Product data sheet** 

#### **General description** 1

The 74CBTLV3257 provides a quad 1-of-2 high-speed multiplexer/demultiplexer with common select (S) and output enable (OE) inputs. The low ON resistance of the switch allows inputs to be connected to outputs without adding propagation delay or generating additional ground bounce noise. When pin  $\overline{OE} = LOW$ , one of the two switches is selected (low-impedance ON-state) with pin S. When pin  $\overline{OE}$  = HIGH, all switches are in the high-impedance OFF-state, independent of pin S.

Schmitt trigger action at control input makes the circuit tolerant to slower input rise and fall times across the entire  $V_{CC}$  range from 2.3 V to 3.6 V.

To ensure the high-impedance OFF-state during power-up or power-down, OE should be tied to the V<sub>CC</sub> through a pull-up resistor. The minimum value of the resistor is determined by the current-sinking capability of the driver.

This device is fully specified for partial power-down applications using I<sub>OFF</sub>. The I<sub>OFF</sub> circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

#### Features and benefits 2

- Supply voltage range from 2.3 V to 3.6 V
- High noise immunity
- · Complies with JEDEC standard:
  - JESD8-5 (2.3 V to 2.7 V)
  - JESD8-B/JESD36 (2.7 V to 3.6 V)
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
  - CDM AEC-Q100-011 revision B exceeds 1000 V
- 5 Ω switch connection between two ports
- Rail to rail switching on data I/O ports
- CMOS low power consumption
- Latch-up performance exceeds 250 mA per JESD78B Class I level A
- I<sub>OFF</sub> circuitry provides partial Power-down mode operation
- · Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



## 3 Ordering information

**Table 1. Ordering information** 

Type number	Package	Package								
	Temperature range	Name	Description	Version						
74CBTLV3257D	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1						
74CBTLV3257DS	-40 °C to +125 °C	SSOP16 <sup>[1]</sup>	plastic shrink small outline package; 16 leads; body width 3.9 mm; lead pitch 0.635 mm	SOT519-1						
74CBTLV3257PW	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1						
74CBTLV3257BQ	-40 °C to +125 °C	DHVQFN16	plastic dual-in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm	SOT763-1						
74CBTLV3257GU	-40 °C to +125 °C	XQFN16	plastic, extremely thin quad flat package; no leads; 16 terminals; body 1.80 x 2.60 x 0.50 mm	SOT1161-1						

<sup>[1]</sup> Also known as QSOP16.

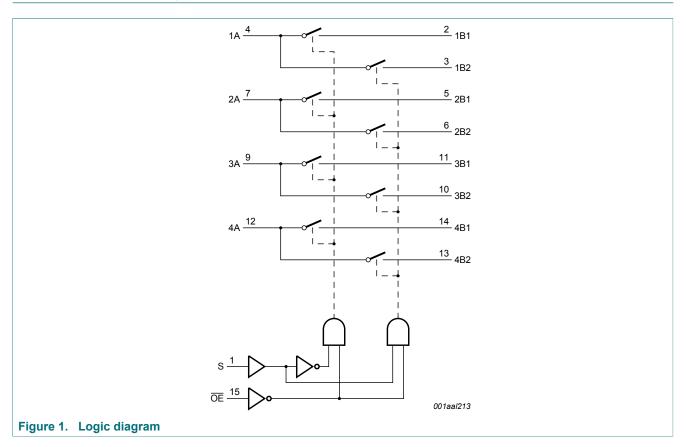
## 4 Marking

Table 2. Marking codes

Type number	Marking code <sup>[1]</sup>
74CBTLV3257D	74CBTLV3257D
74CBTLV3257DS	TLV3257
74CBTLV3257PW	TLV3257
74CBTLV3257BQ	TV3257
74CBTLV3257GU	b57

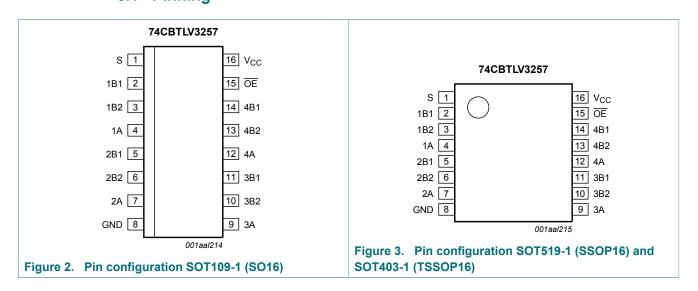
<sup>[1]</sup> The pin 1 indicator is located on the lower left corner of the device, below the marking code.

## 5 Functional diagram



## 6 Pinning information

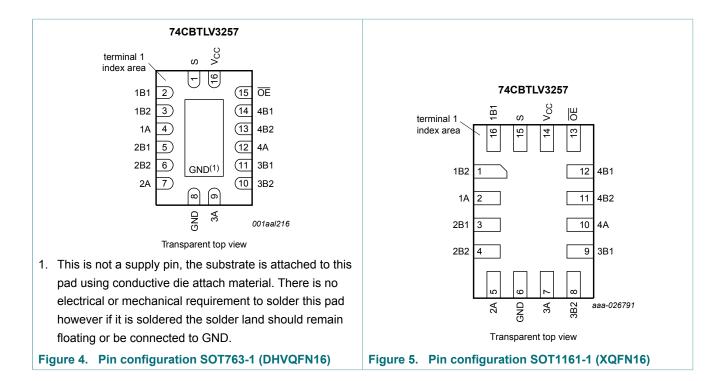
#### 6.1 Pinning



74CBTLV3257

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#### 6.2 Pin description

Table 3. Pin description

Symbol	Pin	Pin			
	SO16, (T)SSOP16 and DHVQFN16	XQFN16			
S	1	15	select input		
1B1 to 4B1	2, 5, 11, 14	16, 3, 9, 12	B1 input/output		
1B2 to 4B2	3, 6, 10, 13	1, 4, 8, 11	B2 input/output		
1A to 4A	4, 7, 9, 12	2, 5, 7, 10	A input/output		
GND	8	6	ground (0 V)		
ŌĒ	15	13	output enable input (active LOW)		
$V_{CC}$	16	14	supply voltage		

## 7 Functional description

#### Table 4. Function table

 $H = HIGH \ voltage \ level; \ L = LOW \ voltage \ level.$ 

Inputs		Function switch		
OE	S			
L	L	nA = nB1		
L	Н	nA = nB2		
Н	Х	disconnect nA and nBn		

74CBTLV3257

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## **Limiting values**

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage			-0.5	+4.6	V
VI	input voltage	control inputs	[1]	-0.5	+4.6	V
V <sub>SW</sub>	switch voltage	enable and disable mode	[2]	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < -0.5 V		-50	-	mA
I <sub>SK</sub>	switch clamping current	V <sub>I</sub> < -0.5 V		-50	-	mA
I <sub>SW</sub>	switch current	V <sub>SW</sub> = 0 V to V <sub>CC</sub>		-	±128	mA
I <sub>CC</sub>	supply current			-	+100	mA
I <sub>GND</sub>	ground current			-100	-	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = -40 °C to +125 °C				
		SO16, (T)SSOP16 and DHVQFN16 packages	[3]	-	500	mW
		XQFN16 package		-	250	mW

 <sup>[1]</sup> The minimum input voltage rating may be exceeded if the input clamping current ratings are observed.
 [2] The switch voltage ratings may be exceeded if switch clamping current ratings are observed
 [3] For SSOP16 and TSSOP16 packages: P<sub>tot</sub> derates linearly with 5.5 mW/K above 60 °C.

## **Recommended operating conditions**

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		2.3	3.6	V
VI	input voltage		0	3.6	V
V <sub>SW</sub>	switch voltage	enable and disable mode	0	$V_{CC}$	V
T <sub>amb</sub>	ambient temperature		-40	+125	°C
Δt/ΔV	input transition rise and fall rate	$V_{CC} = 2.3 \text{ V to } 3.6 \text{ V}$ [1]	0	200	ns/V

<sup>[1]</sup> Applies to control signal levels.

For DHVQFN16 packages: Ptot derates linearly with 4.5 mW/K above 60 °C.

### 10 Static characteristics

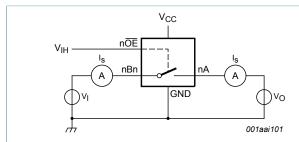
**Table 7. Static characteristics** 

At recommended operating conditions voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>amb</sub> =	-40 °C to	+85 °C	T <sub>amb</sub> = -40 °	$T_{amb}$ = -40 °C to +125 °C		
			Min	Typ <sup>[1]</sup>	Max	Min	Max		
V <sub>IH</sub>	HIGH-level	V <sub>CC</sub> = 2.3 V to 2.7 V	1.7	-	-	1.7	-	V	
	input voltage	V <sub>CC</sub> = 3.0 V to 3.6 V	2.0	-	-	2.0	-	V	
V <sub>IL</sub>	LOW-level input	V <sub>CC</sub> = 2.3 V to 2.7 V	-	-	0.7	-	0.7	V	
	voltage	V <sub>CC</sub> = 3.0 V to 3.6 V	-	-	0.9	-	0.9	V	
I <sub>1</sub>	input leakage current	pin $\overline{OE}$ , S; $V_{CC}$ = 3.6 V; $V_{I}$ = GND to $V_{CC}$	-	-	±1	-	±20	μΑ	
I <sub>S(OFF)</sub>	OFF-state leakage current	V <sub>CC</sub> = 3.6 V; see <u>Figure 6</u>	-	-	±1	-	±20	μΑ	
I <sub>S(ON)</sub>	ON-state leakage current	V <sub>CC</sub> = 3.6 V; see <u>Figure 7</u>	-	-	±1	-	±20	μΑ	
I <sub>OFF</sub>	power-off leakage current	$V_1 \text{ or } V_0 = 0 \text{ V to } 3.6 \text{ V};$ $V_{CC} = 0 \text{ V}$	-	-	±10	-	±50	μΑ	
I <sub>CC</sub>	supply current	$V_I$ = GND or $V_{CC}$ ; $V_{SW}$ = GND or $V_{CC}$ ; $V_{CC}$ = 3.6 V; $I_O$ = 0 A	-	-	10	-	50	μΑ	
ΔI <sub>CC</sub>	additional supply current	pin $\overline{OE}$ , S; $V_{CC}$ = 3.6 V; $V_{I} = V_{CC}$ - 0.6 V; $V_{SW}$ = GND or $V_{CC}$	-	-	300	-	2000	μA	
Cı	input capacitance	pin $\overline{OE}$ , S; V <sub>CC</sub> = 3.3 V; V <sub>I</sub> = 0 V to 3.3 V	-	0.9	-	-	-	pF	
C <sub>S(OFF)</sub>	OFF-state capacitance	V <sub>CC</sub> = 3.3 V; V <sub>I</sub> = 0 V to 3.3 V	-	5.2	-	-	-	pF	
C <sub>S(ON)</sub>	ON-state capacitance	V <sub>CC</sub> = 3.3 V; V <sub>I</sub> = 0 V to 3.3 V	-	14.3	-	-	-	pF	

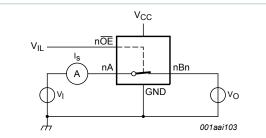
<sup>[1]</sup> All typical values are measured at  $T_{amb}$  = 25 °C. [2] One input at 3 V, other inputs at  $V_{CC}$  or GND.

#### 10.1 Test circuits



 $V_I = V_{CC}$  or GND and  $V_O = GND$  or  $V_{CC}$ .

Figure 6. Test circuit for measuring OFF-state leakage current (one switch)



 $V_I = V_{CC}$  or GND and  $V_O =$  open circuit.

Figure 7. Test circuit for measuring ON-state leakage current (one switch)

#### 10.2 ON resistance

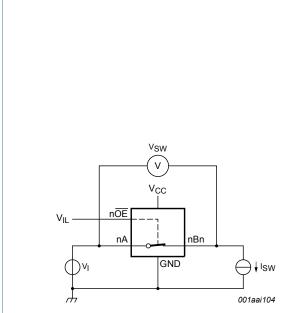
Table 8. Resistance R<sub>ON</sub>

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 8.

Symbol	Parameter	Conditions	T <sub>amb</sub> =	-40 °C to	+85 °C	T <sub>amb</sub> = -40 °	C to +125 °C	Unit
			Min	Typ <sup>[1]</sup>	Max	Min	Max	
R <sub>ON</sub>	ON resistance	V <sub>CC</sub> = 2.3 V to 2.7 V; [2] see <u>Figure 9</u> to <u>Figure 11</u>						
		I <sub>SW</sub> = 64 mA; V <sub>I</sub> = 0 V	-	4.2	8.0	-	15.0	Ω
		I <sub>SW</sub> = 24 mA; V <sub>I</sub> = 0 V	-	4.2	8.0	-	15.0	Ω
		I <sub>SW</sub> = 15 mA; V <sub>I</sub> = 1.7 V	-	8.4	40.0	-	60.0	Ω
		V <sub>CC</sub> = 3.0 V to 3.6 V; see <u>Figure 12</u> to <u>Figure 14</u>						
		I <sub>SW</sub> = 64 mA; V <sub>I</sub> = 0 V	-	4.0	7.0	-	11.0	Ω
		I <sub>SW</sub> = 24 mA; V <sub>I</sub> = 0 V	-	4.0	7.0	-	11.0	Ω
		I <sub>SW</sub> = 15 mA; V <sub>I</sub> = 2.4 V	-	6.2	15.0	-	25.5	Ω

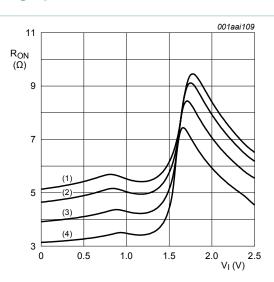
Typical values are measured at T<sub>amb</sub> = 25 °C and nominal V<sub>CC</sub>.
 Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

#### 10.3 ON resistance test circuit and graphs



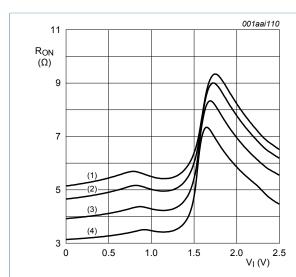
 $R_{ON} = V_{SW} / I_{SW}$ .

Figure 8. Test circuit for measuring ON resistance (one switch)



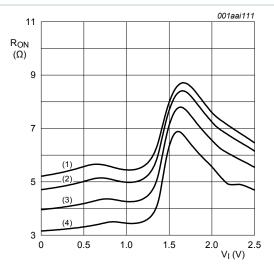
- (1) T<sub>amb</sub> = 125 °C
- (2)  $T_{amb} = 85 \, ^{\circ}C$
- (3)  $T_{amb}$  = 25 °C
- (4)  $T_{amb} = -40 \, ^{\circ}C$

Figure 9. ON resistance as a function of input voltage;  $V_{CC} = 2.5 \text{ V}$ ;  $I_{SW} = 15 \text{ mA}$ 



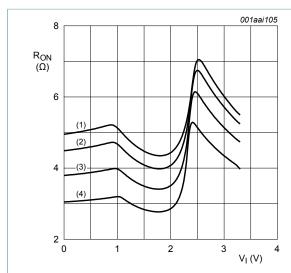
- (1)  $T_{amb} = 125 \, ^{\circ}C$
- (2)  $T_{amb}$  = 85 °C
- (3)  $T_{amb} = 25 \, ^{\circ}C$
- (4)  $T_{amb} = -40 \, ^{\circ}C$

Figure 10. ON resistance as a function of input voltage;  $V_{CC}$  = 2.5 V;  $I_{SW}$  = 24 mA



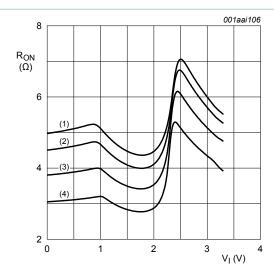
- (1)  $T_{amb} = 125 \, ^{\circ}C$
- (2)  $T_{amb}$  = 85 °C
- (3)  $T_{amb} = 25 \, ^{\circ}C$
- (4)  $T_{amb} = -40 \, ^{\circ}C$

Figure 11. ON resistance as a function of input voltage;  $V_{CC}$  = 2.5 V;  $I_{SW}$  = 64 mA



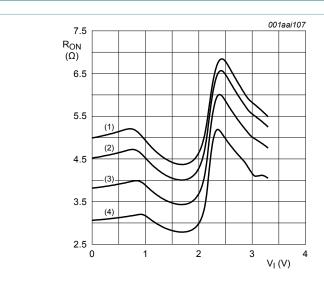
- (1)  $T_{amb} = 125 \, ^{\circ}C$
- (2)  $T_{amb}$  = 85 °C
- (3)  $T_{amb} = 25 \, ^{\circ}C$
- (4)  $T_{amb}$  = -40 °C

Figure 12. ON resistance as a function of input voltage;  $V_{CC}$  = 3.3 V;  $I_{SW}$  = 15 mA



- (1)  $T_{amb} = 125 \, ^{\circ}C$
- (2)  $T_{amb}$  = 85 °C
- (3)  $T_{amb}$  = 25 °C
- (4)  $T_{amb} = -40 \, ^{\circ}C$

Figure 13. ON resistance as a function of input voltage;  $V_{CC} = 3.3 \text{ V}$ ;  $I_{SW} = 24 \text{ mA}$ 



- (1)  $T_{amb} = 125 \, ^{\circ}C$
- (2)  $T_{amb}$  = 85 °C
- (3)  $T_{amb} = 25 \, ^{\circ}C$
- (4)  $T_{amb}$  = -40 °C

Figure 14. ON resistance as a function of input voltage;  $V_{CC}$  = 3.3 V;  $I_{SW}$  = 64 mA

## 11 Dynamic characteristics

Table 9. Dynamic characteristics

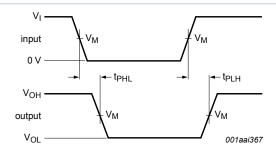
GND = 0 V; for test circuit see Figure 17

Symbol	Parameter	Conditions		T <sub>amb</sub> =	-40 °C to	+85 °C	T <sub>amb</sub> = -40 °	C to +125 °C	Unit
				Min	Typ <sup>[1]</sup>	Max	Min	Max	
t <sub>pd</sub>	propagation delay	nA to nBn or nBn to nA; see Figure 15	[2] [3]						
		V <sub>CC</sub> = 2.3 V to 2.7 V		-	-	0.15	-	0.25	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		-	-	0.15	-	0.25	ns
		S to nA; see Figure 14	[3]						
		V <sub>CC</sub> = 2.3 V to 2.7 V		1.0	3.8	6.1	1.0	6.7	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		1.0	3.2	5.3	1.0	5.8	ns
t <sub>en</sub>	enable time	OE to nA or nBn; see Figure 16	[4]						
		V <sub>CC</sub> = 2.3 V to 2.7 V		1.0	2.2	5.6	1.0	6.2	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		1.0	2.0	5.0	1.0	5.5	ns
		S to nBn; see Figure 16							
		V <sub>CC</sub> = 2.3 V to 2.7 V		1.0	3.5	6.1	1.0	6.7	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		1.0	3.0	5.3	1.0	5.8	ns
t <sub>dis</sub>	disable time	OE to nA or nBn; see Figure 16	[5]						
		V <sub>CC</sub> = 2.3 V to 2.7 V		1.0	2.6	5.5	1.0	6.1	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		1.0	3.1	5.5	1.0	6.1	ns
		S to nBn; see Figure 16							
		V <sub>CC</sub> = 2.3 V to 2.7 V		1.0	2.6	4.8	1.0	5.3	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		1.0	3.2	4.5	1.0	5.0	ns

 <sup>[1]</sup> All typical values are measured at T<sub>amb</sub> = 25 °C and at nominal V<sub>CC</sub>.
 [2] The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the load capacitance, when driven by an ideal voltage source (zero output impedance).

 <sup>[3]</sup> t<sub>pd</sub> is the same as t<sub>PLH</sub> and t<sub>PHL</sub>.
 [4] t<sub>en</sub> is the same as t<sub>PZH</sub> and t<sub>PZL</sub>.
 [5] t<sub>dis</sub> is the same as t<sub>PHZ</sub> and t<sub>PLZ</sub>.

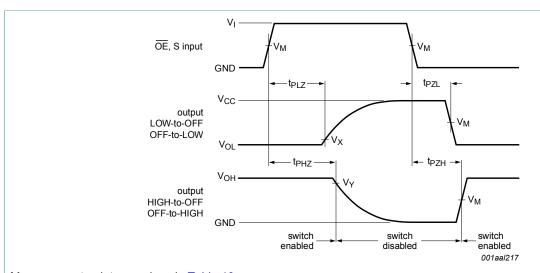
#### 11.1 Waveforms and test circuit



Measurement points are given in Table 10.

Logic levels:  $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical output voltage levels that occur with the output load.

Figure 15. The data input (nA or nBn) to output (nBn or nA) propagation delays



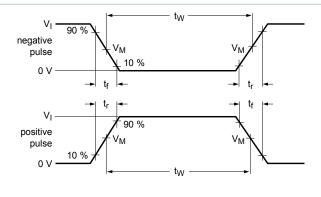
Measurement points are given in <u>Table 10</u>.

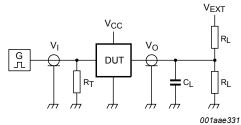
Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

Figure 16. Enable and disable times

Table 10. Measurement points

Supply voltage	Input			Output			
V <sub>CC</sub>	V <sub>M</sub>	VI	t <sub>r</sub> = t <sub>f</sub>	V <sub>M</sub>	$V_X$	V <sub>Y</sub>	
2.3 V to 2.7 V	0.5V <sub>CC</sub>	V <sub>CC</sub>	≤ 2.0 ns	0.5V <sub>CC</sub>	V <sub>OL</sub> + 0.15 V	V <sub>OH</sub> - 0.15 V	
3.0 V to 3.6 V	0.5V <sub>CC</sub>	V <sub>CC</sub>	≤ 2.0 ns	0.5V <sub>CC</sub>	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> - 0.3 V	





Test data is given in Table 11.

Definitions for test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

 $V_{EXT}$  = External voltage for measuring switching times.

Figure 17. Test circuit for measuring switching times

Table 11. Test data

Supply voltage	Load		V <sub>EXT</sub>				
V <sub>CC</sub>	CL	R <sub>L</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>		
2.3 V to 2.7 V	30 pF	500 Ω	open	GND	2V <sub>CC</sub>		
3.0 V to 3.6 V	50 pF	500 Ω	open	GND	2V <sub>CC</sub>		

#### 11.2 Additional dynamic characteristics

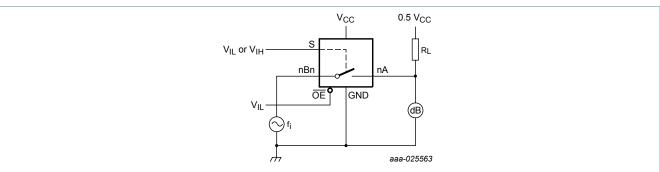
#### Table 12. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V);  $V_I$  = GND or  $V_{CC}$  (unless otherwise specified);  $t_r$  =  $t_f \le 2.5$  ns.

Symbol	Parameter	Conditions		T <sub>amb</sub> = 25 °C		3	Unit
				Min	Тур	Max	
f <sub>(-3dB)</sub>	-3 dB frequency response	$V_{CC}$ = 3.3 V; $R_L$ = 50 $\Omega$ ; see <u>Figure 18</u>	[1]	-	398	-	MHz

[1]  $f_i$  is biased at  $0.5V_{CC}$ .

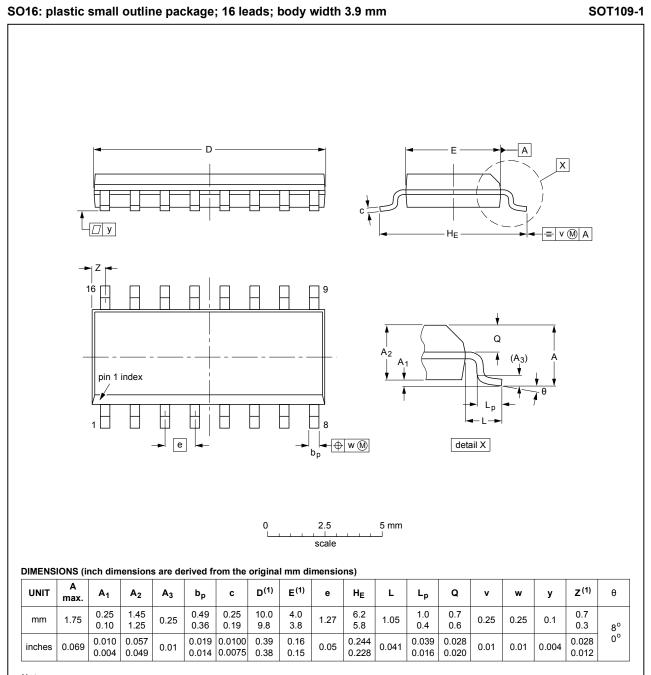
#### 11.3 Test circuit



 $\overline{\text{OE}}$  connected to GND; Adjust f<sub>i</sub> voltage to obtain 0 dBm level at output. Increase f<sub>i</sub> frequency until dB meter reads -3 dB.

Figure 18. Test circuit for measuring the frequency response when channel is in ON-state

## 12 Package outline



#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT109-1	076E07	MS-012				<del>99-12-27</del> 03-02-19

Figure 19. Package outline SOT109-1 (SO16)

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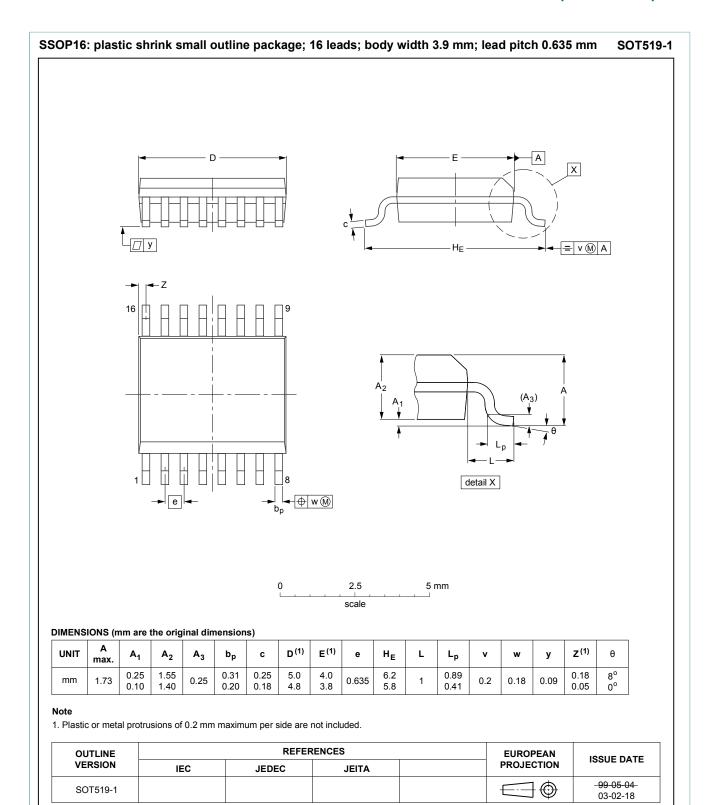
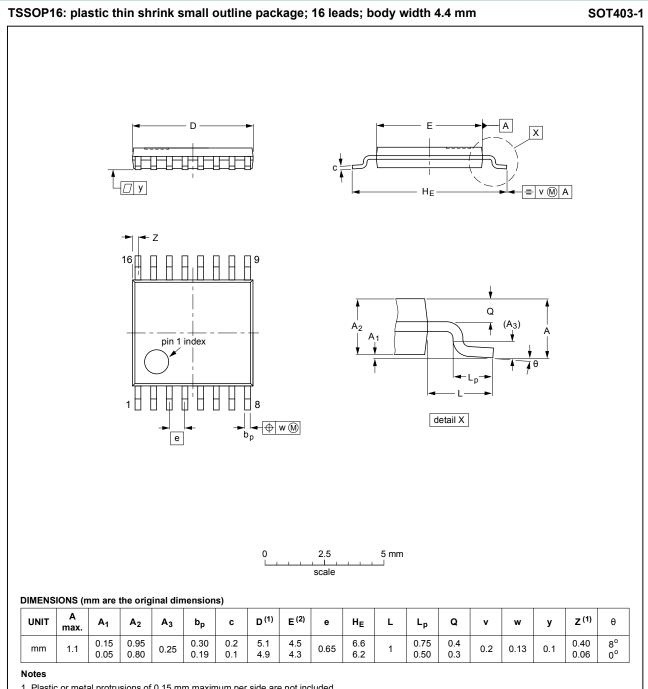


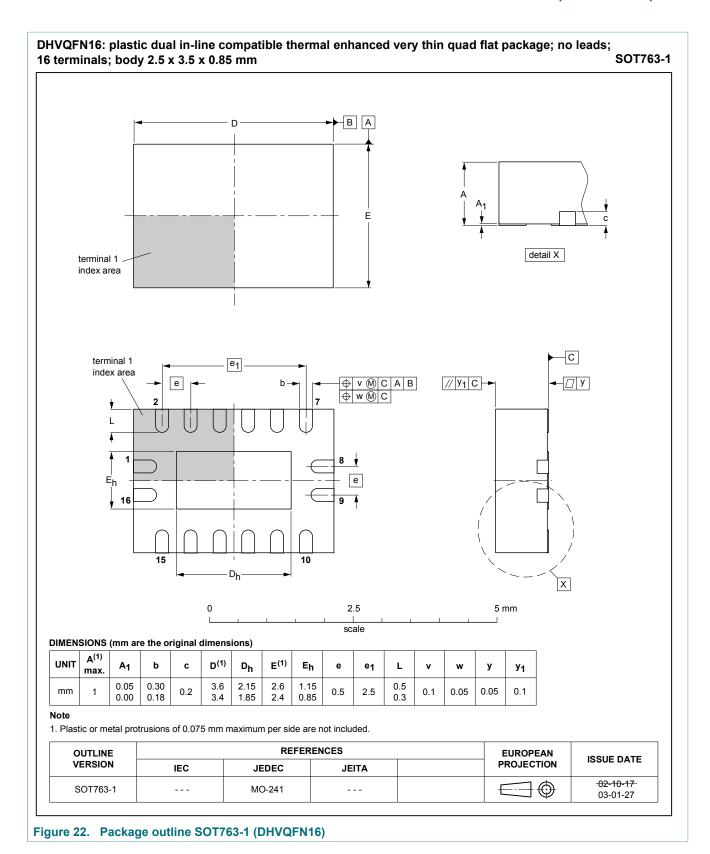
Figure 20. Package outline SOT519-1 (SSOP16)

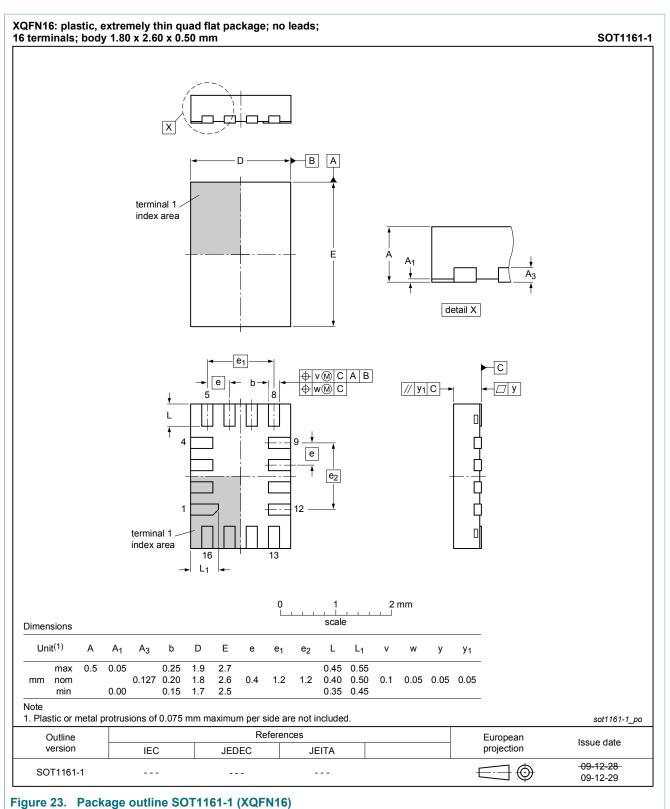


- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT403-1		MO-153				<del>99-12-27</del> 03-02-18

Figure 21. Package outline SOT403-1 (TSSOP16)





Tigure 20. Tuckage outline COTTTOT-T (XQTTTT

## 13 Abbreviations

#### Table 13. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model

## 14 Revision history

#### Table 14. Revision history

Table 14. Revision history						
Release date	Data sheet status	Change notice	Supersedes			
20171211	Product data sheet	-	74CBTLV3257 v.5			
Type number 74	CBTLV3257GU (SOT1161-1	XQFN16) added.				
20161111	Product data sheet	-	74CBTLV3257 v.4			
Section 11.2 and Section 11.3 added.						
20111216	Product data sheet	-	74CBTLV3257 v.3			
Legal pages updated.						
20110106	Product data sheet	-	74CBTLV3257 v.2			
20101126	Product data sheet	-	74CBTLV3257 v.1			
20100112	Product data sheet	-	-			
	Release date 20171211  Type number 74 20161111  Section 11.2 and 20111216  Legal pages upd 20110106 20101126	Release date  Data sheet status  20171211  Product data sheet  Type number 74CBTLV3257GU (SOT1161-1)  20161111  Product data sheet  Section 11.2 and Section 11.3 added.  20111216  Product data sheet  Legal pages updated.  20110106  Product data sheet  Product data sheet  Product data sheet	Release date Data sheet status Change notice  20171211 Product data sheet -  • Type number 74CBTLV3257GU (SOT1161-1 / XQFN16) added.  20161111 Product data sheet -  • Section 11.2 and Section 11.3 added.  20111216 Product data sheet -  • Legal pages updated.  20110106 Product data sheet -  20101126 Product data sheet -			

## 15 Legal information

#### 15.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- The term 'short data sheet' is explained in section "Definitions". [2] [3]
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